

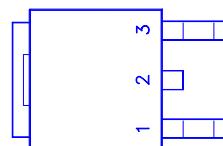
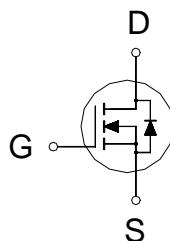
**NIKO-SEM**
**N-Channel Logic Level Enhancement  
Mode Field Effect Transistor**
**P45N02LDG**

TO-252 (DPAK)

Lead-Free

**PRODUCT SUMMARY**

$V_{(BR)DSS}$	$R_{DS(ON)}$	$I_D$
25	20m	45A



1. GATE
2. DRAIN
3. SOURCE

**ABSOLUTE MAXIMUM RATINGS ( $T_c = 25^\circ\text{C}$  Unless Otherwise Noted)**

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Gate-Source Voltage		$V_{GS}$	$\pm 20$	V
Continuous Drain Current	$T_c = 25^\circ\text{C}$	$I_D$	45	A
	$T_c = 100^\circ\text{C}$		28	
Pulsed Drain Current <sup>1</sup>		$I_{DM}$	140	A
Avalanche Current		$I_{AR}$	20	
Avalanche Energy	$L = 0.1\text{mH}$	$E_{AS}$	140	mJ
Repetitive Avalanche Energy <sup>2</sup>	$L = 0.05\text{mH}$	$E_{AR}$	5.6	
Power Dissipation	$T_c = 25^\circ\text{C}$	$P_D$	55	W
	$T_c = 100^\circ\text{C}$		33	
Operating Junction & Storage Temperature Range		$T_j, T_{stg}$	-55 to 150	°C
Lead Temperature ( $1/16$ " from case for 10 sec.)		$T_L$	275	

**THERMAL RESISTANCE RATINGS**

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Case	$R_{\theta JC}$		3	
Junction-to-Ambient	$R_{\theta JA}$		70	°C / W
Case-to-Heatsink	$R_{\theta CS}$	0.7		

<sup>1</sup>Pulse width limited by maximum junction temperature.<sup>2</sup>Duty cycle  $\leq 1\%$ **ELECTRICAL CHARACTERISTICS ( $T_c = 25^\circ\text{C}$ , Unless Otherwise Noted)**

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
<b>STATIC</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$	25			V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	0.8	1.2	2.5	
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$			$\pm 250$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$			25	$\mu\text{A}$
		$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}, T_J = 125^\circ\text{C}$			250	
On-State Drain Current <sup>1</sup>	$I_{D(\text{ON})}$	$V_{DS} = 10\text{V}, V_{GS} = 10\text{V}$	45			A

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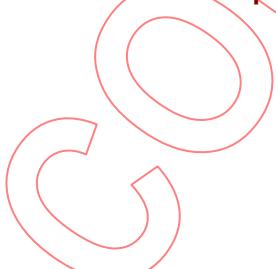
TO-252 (DPAK)

Lead-Free

Drain-Source On-State Resistance <sup>1</sup>	$R_{DS(ON)}$	$V_{GS} = 7V, I_D = 18A$		20	30	m
		$V_{GS} = 10V, I_D = 20A$		15	28	
Forward Transconductance <sup>1</sup>	$g_{fs}$	$V_{DS} = 15V, I_D = 30A$		16		S
<b>DYNAMIC</b>						
Input Capacitance	$C_{iss}$	$V_{GS} = 0V, V_{DS} = 15V, f = 1MHz$		600		pF
Output Capacitance	$C_{oss}$			290		
Reverse Transfer Capacitance	$C_{rss}$			100		
Total Gate Charge <sup>2</sup>	$Q_g$			25		nC
Gate-Source Charge <sup>2</sup>	$Q_{gs}$			2.9		
Gate-Drain Charge <sup>2</sup>	$Q_{gd}$			7.0		
Turn-On Delay Time <sup>2</sup>	$t_{d(on)}$			7.0		nS
Rise Time <sup>2</sup>	$t_r$			7.0		
Turn-Off Delay Time <sup>2</sup>	$t_{d(off)}$			24		
Fall Time <sup>2</sup>	$t_f$			6.0		
<b>SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (<math>T_c = 25^\circ C</math>)</b>						
Continuous Current	$I_S$	$V_{DS} = 0.5V_{(BR)DSS}, V_{GS} = 10V, I_D = 20A$			45	A
Pulsed Current <sup>3</sup>	$I_{SM}$				150	
Forward Voltage <sup>1</sup>	$V_{SD}$				1.3	V
Reverse Recovery Time	$t_{rr}$				37	nS
Peak Reverse Recovery Current	$I_{RM(REC)}$				200	A
Reverse Recovery Charge	$Q_{rr}$				0.043	$\mu C$

<sup>1</sup>Pulse test : Pulse Width  $\leq 300 \mu sec$ , Duty Cycle  $\leq 2\%$ .<sup>2</sup>Independent of operating temperature.<sup>3</sup>Pulse width limited by maximum junction temperature.**REMARK: THE PRODUCT MARKED WITH "P45N02LDG", DATE CODE or LOT #**

Orders for parts with Lead-Free plating can be placed using the PXXXXXXG parts name



**NIKO-SEM**

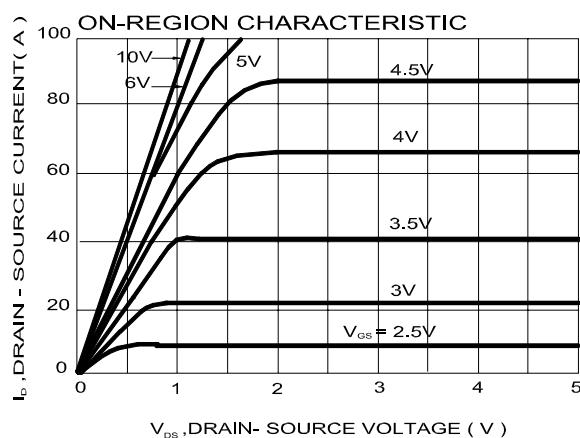
**N-Channel Logic Level Enhancement  
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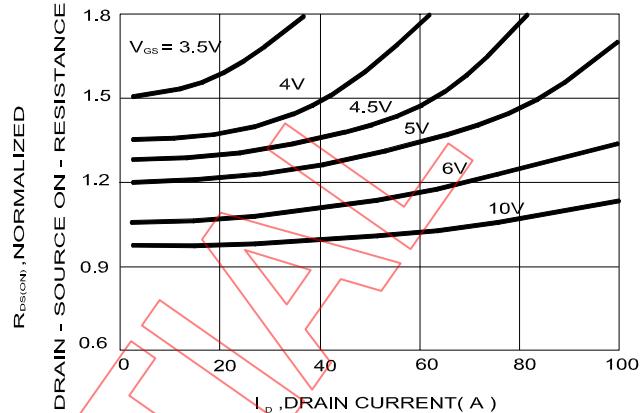
**TO-252 (DPAK)**

**Lead-Free**

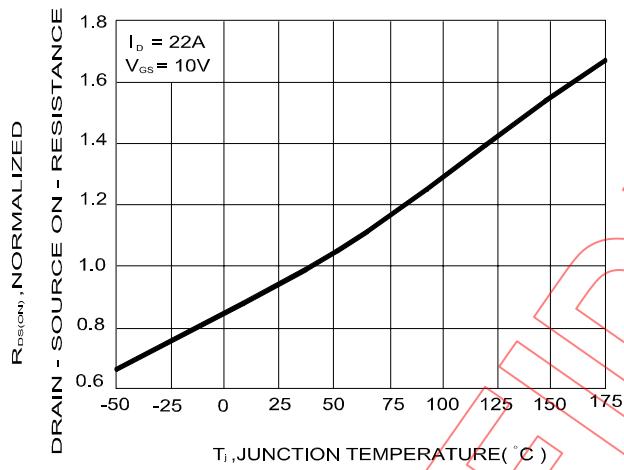
**TYPICAL CHARACTERISTICS**



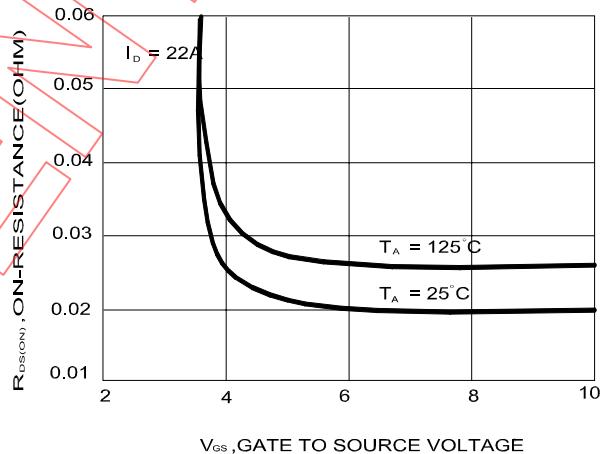
ON-RESISTANCE VARIATION WITH DRAIN CURRENT AND GATE



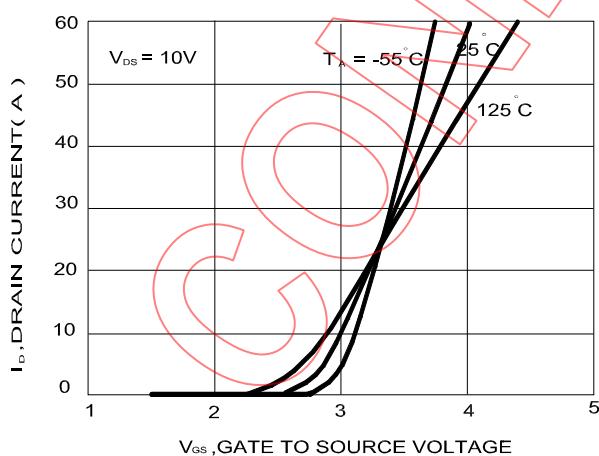
ON-RESISTANCE VARIATION WITH TEMPERATURE



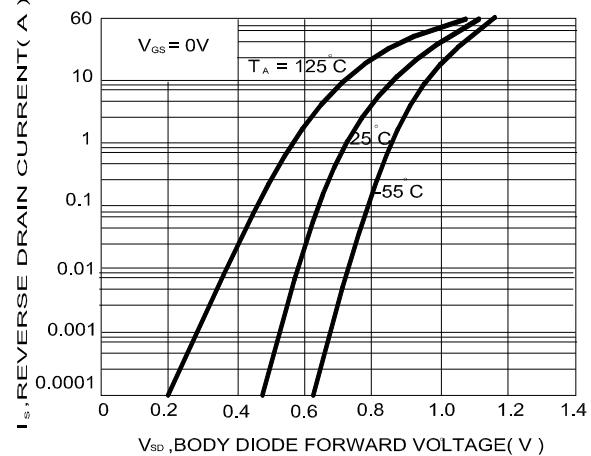
ON-RESISTANCE VARIATION WITH GATE-TO-SOURCE VOLTAGE

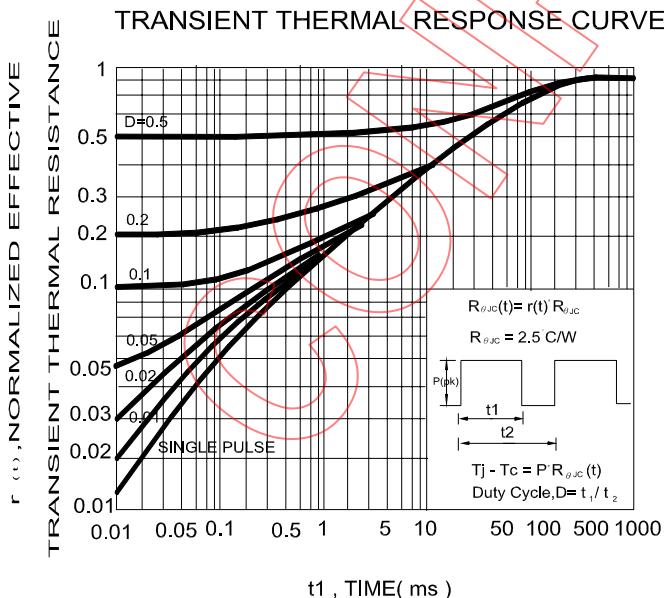
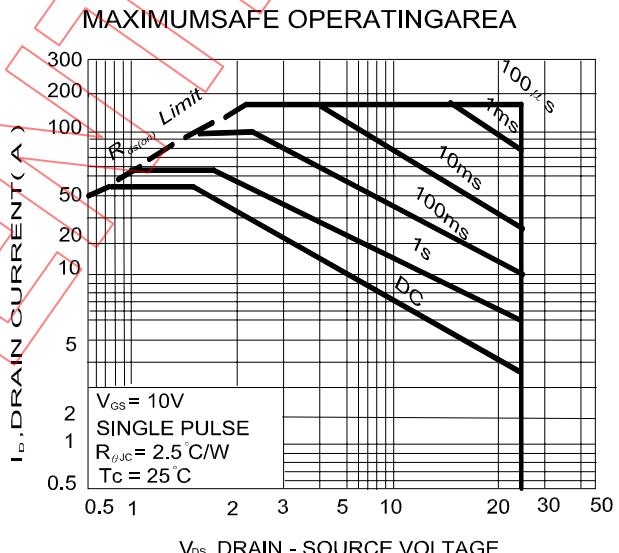
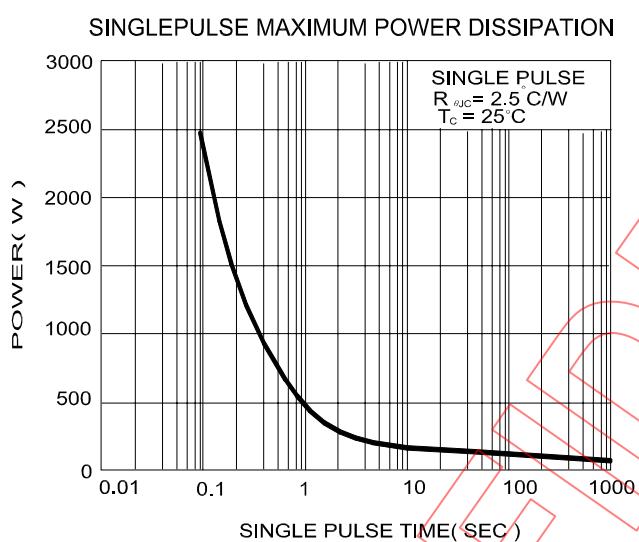
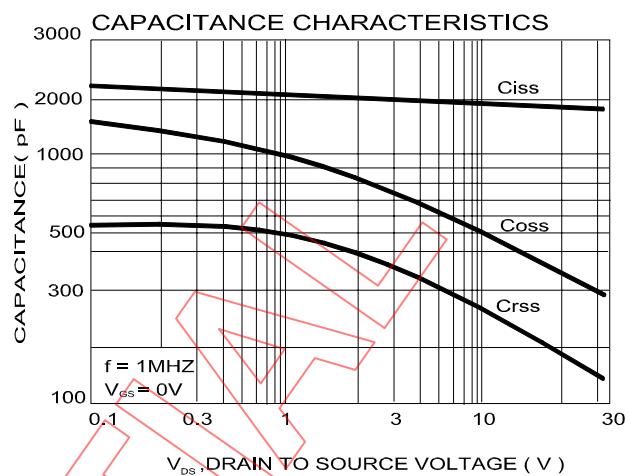
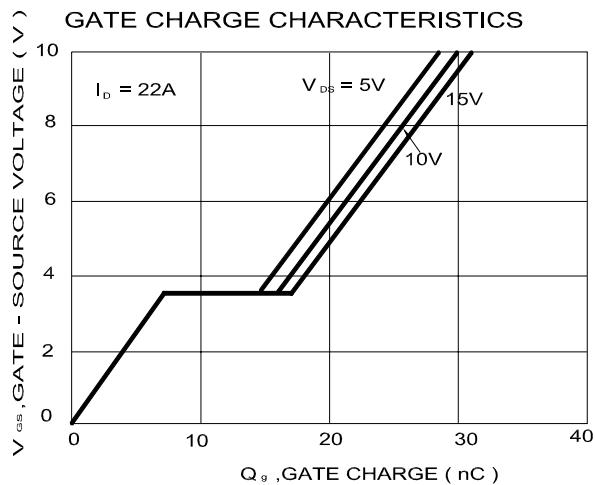


TRANSFER CHARACTERISTICS



BODY DIODE FORWARD VOLTAGE VARIATION WITH SOURCE CURRENT AND TEMPERATURE



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**NIKO-SEM****N-Channel Logic Level Enhancement  
Mode Field Effect Transistor****P45N02LDG****TO-252 (DPAK)****Lead-Free****TO-252 (DPAK) MECHANICAL DATA**

Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	9.35		10.4	H	0.89		2.03
B	2.2		2.4	I	6.35		6.80
C	0.45		0.6	J	5.2		5.5
D	0.89		1.5	K	0.6		1
E	0.45		0.69	L	0.5		0.9
F	0.03		0.23	M	3.96	4.57	5.18
G	5.2		6.2	N			

